

04/08/2013

Federal Communications Commission Office of Engineering and Technology Laboratory Division Public Draft Review

Draft Laboratory Division Publications Report

Title: Preliminary SAR Test Considerations for LTE Handsets and Data Modems

Short Title: SAR for LTE Devices

Reason: Revision of Attachment 941225 D05 SAR for LTE Devices

Publication: 941225

Keyword/Subject: SAR Test Procedures, 3G Devices, 2.5G, GPS/GPRS/Edge, Dual Xfer Mode, 2.1093

First Category: Administrative Requirements

Second Category: Measurement Procedures

Third Category:

Question: What are the current SAR test procedures for 3G devices?

Answer:

Attached document - 941225 D01 SAR test for 3G devices v02- provides the SAR test procedures for 3G devices that operate under rule Parts 22H, 24E, 27L are described in the attached document.

Attached document- 941225 D02 Guidance for 3GPP R6 and R7 HSPA v02v02 - provides guidance 3GPP R6-HSPA and R7 HSPA plus SAR testing.

Attached document- 941225 D03 SAR Test Reduction GSM GPRS EDGE v01 - provides SAR Test Reduction Procedures for 3G devices with GSM/GPRS/EDGE modes (also applicable to 2.5G with the same GSM/GPRS/EDGE modes).

Attached document- 941225 D04 SAR for GSM E GPRS Dual Xfer Mode v01 - provides SAR test procedures for GSM/(E)GPRS Dual Transfer Mode operation.

Attached document- 941225 D05 SAR for LTE Devices v02r02- provides SAR test procedures for devices incorporating Long Term Evolution (LTE) capabilities. See transition period note below.

Attached document- 941225 D06 Hot Spot SAR v01r01 - provides SAR test procedures for devices incorporating SAR Evaluation Procedures for Portable Devices with Wireless Router Capabilities (Hot Spot SAR)..

Attached document- 941225 D07 UMPC Mini Tablet Devices v01r01 - provides SAR Evaluation Procedures for UMPC Mini-Tablet Devices



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These procedures must be used for applications submitted to TCBs for approval. Questions about using alternative procedures should be submitted to http://www.fcc.gov/labhelp and then use the link "Submit An Inquiry" to access the form to submit your question.

Attachment List:

941225 D01 SAR test for 3G devices v02¹ 941225 D02 Guidance for 3GPP R6 and R7 HSPA v02r02² 941225 D03 SAR Test Reduction GSM GPRS EDGE v01¹ 941225 D04 SAR for GSM E GPRS Dual Xfer Mode v01¹ 941225 **D05 SAR for LTE Devices v02r02³** 941225 D06 Hot Spot SAR v01r01⁴ 941225 D07 UMPC Mini Tablet Devices v01r01⁵



¹ Attachments are currently in KDB 941225 and are not under draft review.

² <u>941225 D02 Guidance for 3GPP R6 and R7 HSPA v02r02</u> is also available for review (until May 15th 2013), posted as a separate draft publications: <u>941225 D02 Guidance for 3GPP R6 and R7 HSPA v02r02 DR06-413722</u>. Comments to D02 must be filed under that separate draft posting and not under this draft posting.

³ This draft is for attachment <u>941225 D05 SAR for LTE Devices v02r02</u> which will be published by May 20, 2013. Prior to publication, applicants can use this draft guidance during the interim period for compliance testing.

⁴ <u>941225 D06 Hot Spot SAR v01r01</u> is also available for review (until May 15th 2013), posted as a separate draft publications: <u>941225 D06 Hot Spot SAR v01r01 DR08-41372</u>. Comments to D06 must be filed under that separate draft posting and not under this draft posting.

⁵ <u>941225 D07 UMPC Mini Tablet Devices v01r01</u> is also available for review (until May 15th 2013), posted as a separate draft publications: <u>941225 D07 UMPC Mini Tablet Devices v01r01 DR09-41372</u>. Comments to D07 must be filed under that separate draft posting and not under this draft posting.



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Attachment: D05 SAR for LTE Devices v02r02

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SAR Evaluation Considerations for LTE Devices

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1. Introduction

This document provides SAR test guidance for devices incorporating Long Term Evolution (LTE) capabilities. The procedures in this revision <u>are intended for Release 8 LTE and</u> have been compiled based on test experiences from the earlier version of the LTE KDB procedures and SAR evaluation concerns associated with recent device implementations.¹ Some of the testing issues are related to variations in maximum output power for different number of resource blocks (RB) allocated using different RB offsets within the channel bandwidth frequency range and for different channels across a frequency band. It is expected that further revisions will be made to these SAR test procedures as more experience is gained in evaluating devices using LTE. For product or manufacturer specific implementations and complex combinations of transmission configurations that are not supported by the procedures, a KDB inquiry is required to determine the SAR test requirements. This revision only applies to Frequency-Division Duplex (FDD) systems. For Time-Division Duplex (TDD) systems, <u>SAR</u> must be tested using a fixed periodic duty factor according to the highest transmission duty factor implemented for the device and supported by the defined <u>3GPP LTE TDD configurations</u>.² When it is unclear, a KDB inquiry is required recommended to determine the SAR test requirements.

2. General Test and Approval Considerations

These LTE procedures are applied in conjunction with the other *published RF exposure KDB procedures* to test specific products; for example, USB dongles (KDB 447498) and wireless handsets (KDB 648474). The PBA procedure is generally not required for LTE devices <u>operating in FDD configurations</u>; except when a properly configured basestation simulator is not used to configure the device for SAR testing or when power reduction applies and it is not based on a single fixed level triggered by a specific wireless operating mode and frequency band or single dedicated mode of operation.³

3. Power Reduction Considerations

There are testing concerns relating to the test configurations required for handsets that implement various forms of fixed and dynamic power reduction schemes to satisfy SAR compliance for simultaneous voice and data transmission; for example, SVLTE and SVDO, etc.⁴ The similar concerns also apply to tablets that require proximity sensors to activate power reduction. In some cases, power reduction is implemented to address internal interference issues within a handset. For products that require power reduction to manage maximum output power in selected operating modes or configurations to satisfy SAR compliance or other equipment certification and operating requirements, a KDB inquiry detailing the power reduction implementations is typically necessary to determine the SAR test configurations required for the antenna configurations and simultaneous transmission conditions. Unless a single fixed level of power reduction is triggered by a specific wireless operating mode and frequency band or triggered by a single dedicated mode of operation when a simultaneous transmission configurations must be determined through KDB inquiries before testing to qualify for TCB approval.

¹ Provided there are no SAR testing issues, the procedures may be applied to Release 9 LTE devices. When unclear, a KDB inquiry should be submitted to determine the test requirements.

² Interim SAR test guidance is available through the April 2013 TCB workshop slides. When appropriate, the PBA requirement in KDB 388624 may be waived through KDB inquiries.

³ A single fixed level of power reduction for all configurations in a wireless operating mode of a frequency band is required to obviate PBA requirements. In addition, the power reduction must be triggered by a single event or operation; for example, hotspot mode or simultaneous transmission for SVLTE or SVDO etc.

⁴ See KDB 648474 for additional discussions on SVLTE and SVDO, etc.



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4. General LTE SAR Test and Reporting Considerations

In addition to the requirements in KDB 865664 (D02) for reporting RF exposure compliance, the following should be documented in SAR test reports to identify the wireless operating parameters and test configurations for LTE devices.

4.1. Frequency range and channel bandwidth

The frequency range and channel bandwidths (1.4 MHz, 3 MHz, 5 MHz, 10 MHz, 15 MHz, 20 MHz) used in each LTE band must be listed. The high, middle and low (H, M, L) channel numbers and channel frequencies for each channel bandwidth configuration and frequency band must be clearly identified;⁵ these are referred to in this document as the *required test channels*.⁶

4.2. LTE transmitter and antenna implementation

The LTE transmitter and antenna implementation must be described to support the SAR test setup. It should be clearly identified if the transmitter operates independently of the other wireless transmitters in the device; i.e., whether the LTE hardware, components and/or antenna(s) are shared with other transmitters, to support the simultaneous transmission configurations. The voice and data transmission requirements for all LTE operating modes and exposure conditions, for standalone and simultaneous transmission, with respect to the required head and body test configurations, antenna locations, device and accessory operations, antenna diversity requirements, etc. must be clearly identified. The LTE test procedures must be applied separately to each device operating configuration and exposure condition, in each frequency band; for example, the different test positions required for head SAR and various surfaces and edges required by the *published RF exposure KDB procedures*.⁷

4.3. Maximum power reduction (MPR)

It must be clearly identified if Maximum Power Reduction (MPR) is implemented and whether it is an optional or permanent feature, i.e., built-in by design. MPR may be considered during SAR testing only when the maximum output power is permanently limited by the MPR implemented within the device, according to the RB (resource block) configurations specified in 3GPP/LTE standards. Regardless of network requirements, only those RB configurations allowed by 3GPP for the channel bandwidth and modulation combinations may be tested with MPR active. Configurations with RB allocations less than the RB thresholds required by 3GPP must be tested without MPR. A-MPR (additional MPR) must be disabled during SAR testing.

4.4. Power reduction

When power reduction is required for one or more LTE modes to satisfy SAR compliance for simultaneous transmission or other equipment certification and operating requirements, maximum average conducted output power measurement results are required for each power reduction mode applicable to the simultaneous voice/data transmission configurations used by such wireless configurations and frequency bands. The sensing or triggering conditions required to activate and deactivate power reduction, such as antenna or transmitter output conditions, user proximity, etc. must be explained and verified according to the *published RF exposure KDB procedures* or guidance provided through KDB inquiries. The power measurement setup used in the applicable simultaneous transmission and power reduction modes to demonstrate that maximum power is triggered correctly by the

⁵ For LTE bands that do not support at least three non-overlapping channels in certain channel bandwidths, test the available non-overlapping channels instead. When a device supports overlapping channel assignment in a channel bandwidth configuration, the middle channel of the group of overlapping channels should be selected for testing; therefore, the requirement for H, M and L channels may not fully apply.

⁶ If a transmission band is > 100 MHz, the channel selection criteria in KDB 447498 must be applied. A KDB inquiry may be necessary if the channel selection becomes unclear when multiple channel bandwidths are available in a frequency band.

⁷ See KDB 447498 for *published RF exposure KDB procedures*.



specific event or operation and reduced to the required level must be clearly explained in the SAR report. The power measurement data must confirm that the power reduction mechanism operates reliably and consistently for the SAR results to be acceptable.

- 1) When power reduction implementation is based on SAR scaling, acceptable analyses based on SAR and other measurement verifications are required to ensure that a conservative SAR margin is available for each device operating configuration and exposure condition to satisfy compliance. SAR scaling according to device operating power generally only applies to the same operating configuration and exposure condition. Exposure characteristics and SAR distribution are expected to vary from transmitter to transmitter due to design and implementation differences. Even for the same transmitter, SAR cannot be easily scaled across different exposure configurations based on device operating power alone. The power increase allowed by one mode or configuration may not necessarily support an equal amount of power reduction in another mode; especially for different frequency bands and exposure conditions.
- 2) For certain dynamic power reduction configurations, if a device is unable to reduce the maximum output power of one transmitter according to the output or other conditions of another transmitter(s) during SAR testing, the power reduction conditions are usually established or simulated manually through test software configurations to enable SAR measurements. Descriptions of the test equipment, test software, built-in test firmware etc. used to support device testing when power reduction is applied to one or more transmitters/antennas for simultaneous voice/data transmission are required. A KDB inquiry is recommended to confirm the test setup is acceptable.

4.5. Spectrum plots for RB configurations

When a properly configured basestation simulator is not used for the SAR and power measurements, spectrum plots for each RB allocation and offset configuration should be included in the SAR report to demonstrate that the tested RB allocations have been correctly established at the maximum output power conditions.

5. SAR Test Procedures for LTE Devices

5.1. General

The general test requirements of VoIP support for handsets are described in KDB 648474. The head, body, bodyworn accessories and other required test considerations in KDB 447498 and other *published RF exposure KDB procedures* should be applied to configure LTE devices for standalone and simultaneous transmission in voice and data modes for the required exposure conditions.

Based on the design specifications and other information available to the device manufacturer, typically through measurement and analysis during product development, when the maximum output power specifications for different RB allocations and RB offset conditions within a channel bandwidth, modulation, or across the channels in a frequency band varies by more than 1 dB, a KDB inquiry is required to determine whether the *required test channels* are acceptable for SAR testing or if a different set of *required test channels* should be used. The maximum average conducted output power measured according to the following configurations, for the *required test channels*, channel bandwidths and uplink modulations, in each frequency band, according to the following configurations.

- 100% RB allocation
- 1 RB and also 50% RB allocation, offset to the upper edge, middle and lower edge of the channel bandwidth of each *required test channel*

Based on the power measurements, SAR test reduction and exclusion provisions in KDB 447498 should be considered applied for the to determine the SAR evaluationmeasurement requirements. The tests are applied <u>SAR</u> is evaluated separately for the different test positions in each exposure conditions – head, body, body-worn accessories and other use conditions. The configurations and conditions that qualify for SAR test exclusion or



require testing must be clearly explained in the SAR report. The procedures in the following subsections are applied separately to test each LTE frequency band and exposure condition.

5.2. Largest channel bandwidth standalone SAR test requirements

5.2.1. QPSK with 1 RB allocation

Start with the largest channel bandwidth and measure SAR for QPSK with 1 RB allocation, using the RB offset and *required test channel* combination with the highest maximum output power <u>for among</u> RB offsets at the upper edge, middle and lower edge of each *required test channel*. When the <u>reported</u> SAR is ≤ 0.8 W/kg, testing of the remaining RB offset configurations and *required test channels* is not required for 1 RB allocation; otherwise, SAR is required for the remaining *required test channels* and only for the RB offset configuration with the highest output power for that channel.⁸ When the <u>reported</u> SAR of a *required test channel* is > 1.45 W/kg, SAR is required for all three RB offset configurations for that *required test channel*.

5.2.2. QPSK with 50% RB allocation

The procedures required for 1 RB allocation in <u>section</u> 5.2.1 are applied to measure the SAR for QPSK with 50% RB allocation.⁹

5.2.3. QPSK with 100% RB allocation

For QPSK with 100% RB allocation, SAR is not required when the highest maximum output power for 100 % RB allocation is less than the highest maximum output power in 50% and 1 RB allocations and the highest <u>reported</u> SAR for 1 RB and 50% RB allocation in <u>sections</u> 5.2.1 and 5.2.2 are ≤ 0.8 W/kg. Otherwise, SAR is measured for the highest output power channel; and if the <u>reported</u> SAR is > 1.45 W/kg, the remaining required test channels must also be tested.

5.2.4. Higher order modulations

For each modulation besides QPSK; e.g., 16-QAM, 64-QAM, apply the QPSK procedures in sections 5.2.1, 5.2.2 and 5.2.3 to determine the QAM configurations that may need SAR measurement. For each configuration identified as required for testing, SAR is required only when the highest maximum output power for the configuration in the higher order modulation is $> \frac{1}{2}$ dB higher than the same configuration in QPSK or when the *reported* SAR for the QPSK configuration is > 1.45 W/kg.

5.3. Other channel bandwidth standalone SAR test requirements

For the other channel bandwidths used by the device in a frequency band, apply all the procedures required for the largest channel bandwidth in section 5.2 to determine the channels and RB configurations that need SAR testing and only measure SAR when the highest maximum output power of a configuration requiring testing in the smaller channel bandwidth is $> \frac{1}{2}$ dB higher than the equivalent channel configurations in the largest channel bandwidth is $> \frac{1}{2}$ dB higher than the equivalent channel configurations in the largest channel bandwidth configuration or the <u>reported</u> SAR of a configuration for the largest channel bandwidth is > 1.45 W/kg. The equivalent channel configuration for the RB allocation, RB offset and modulation etc. is determined for the smaller channel bandwidth according to the same number of RB allocated in the largest channel bandwidth. For example, 50 RB in 10 MHz channel bandwidth does not apply to 5 MHz channel bandwidth; therefore, this cannot be tested in the smaller channel bandwidth. However, 50% RB allocation in 10 MHz channel bandwidth is equivalent to 100% RB allocation in 5 MHz channel bandwidth; therefore, these are the equivalent configurations to be compared to determine the specific channel and configuration in the smaller channel bandwidth that need SAR testing.

⁸ <u>*Reported*</u> SAR is the measured SAR adjusted for maximum tune-up tolerance.

⁹ Use 3, 8, 12, 25, 36 and 50 RB allocations, respectively, for 1.4 MHz, 3 MHz, 5 MHz, 10 MHz, 15 MHz and 20 MHz channel bandwidths for 50% RB allocation at the upper edge, middle and lower edge of each *required test channel*.



5.4. Simultaneous transmission SAR test considerations for LTE

Standalone SAR results of the individual transmitters and antennas for the frequency bands, operating modes, device operating configurations and exposure conditions are applied to determine simultaneous transmission SAR test requirements, with respect to the applicable *published RF exposure KDB procedures*; for example, voice and data modes in LTE, 1xRTT, WCDMA, GSM, EvDo, HSPA, GPRS/EDGE, WiMax, Wi-Fi, Bluetooth etc. The SAR test reduction and exclusion provisions in KDB 447498 should be applied separately for head, body-worn accessory and other use test conditions according to the channel bandwidths, modulations, RB offsets and allocations in each frequency band.

The conditions and configurations that qualify for test exclusion or reduction must be clearly described in the SAR report. When simultaneous transmission SAR measurement is required, the enlarged zoom scan measurement and volume scan post-processing procedures in KDB 865664 must be applied, in conjunction with the *published RF exposure KDB procedures* required for the product platform and wireless technologies, to each device operating configuration and exposure condition.

Depending on the different combinations of channel bandwidths, modulations, maximum output variations among RB configurations, when LTE devices transmit simultaneously with other wireless modes (for example, Wi-Fi, which has even more data rate, modulation and frequency band combinations), the simultaneous transmission configurations can become very complicated, to the extent that it would be very difficult to develop test procedures to cover all circumstances. When it is unclear, a KDB inquiry should be considered to clarify the test plan or any test concerns to avoid issues during equipment approval.

Change Notice:

10/24/2012 941225 D05 SAR for LTE Devices v02 replaces 941225 D05 SAR for LTE Devices v01. Version v02 represents a major revision to version v01.

04/05/2013 As indicated by track changes in the document.